Notice of References Cited Application/Control No. 09/912,574 Examiner Benny Q. Tieu Applicant(s)/Patent Under Reexamination KIM ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,818,824	10-1998	Lu et al.	370/328
	В	US-6,047,176	04-2000	Sakamoto et al.	455/422.1
	С	US-6,351,649	02-2002	Watanabe et al.	455/501
	D	US-6,493,550	12-2002	Raith, Alex Krister	455/422.1
	Е	US-6,539,237	03-2003	Sayers et al.	455/555
	F	US-2003/0036409	02-2003	Sato et al.	455/561
	G	US-2001/0046860	11-2001	Lee, Dong-Youl	455/426
	Н	US-			·
	ı	US-			
	J	US-			
	К	US-			
	Ĺ	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					•
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		 Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.